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Measurement Services Photonics Laboratory

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Our laboratory performs high accuracy calibrations of your standards and measuring instruments, which are commonly used in the optical fibre and in the photonics domains. Our measurement results are traceable to national standards and thus to internationally supported realizations of the SI units.

The services listed in this catalogue correspond to our standard measurement capabilities. Other services, with e.g. reduced measurement uncertainty or with an extended measurement range, are possible and may be discussed directly with the responsible expert. In addition, our competent lab team is available for consultation and assisting in finding solutions to special requests.

Measurement uncertainty

The measurement uncertainties are supplied for information only and can be evaluated only after the measurements being completed. They contain contributions originating from the measurement standard, from the calibration method, from the environmental conditions and from the device under test. The indicated uncertainty of measurement is stated as the combined standard uncertainty multiplied by a coverage factor k = 2. The measured value (y) and the associated uncertainty (U) represent the interval ($y \pm U$) which contains the value of the measured quantity with a probability of approximately 95 %. The uncertainty is estimated following the guidelines of the ISO.

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1.Fiber-optic measurement instruments

1.1. Powermeter

| Quantity | Optical power, singlemode -10 dBm |
|---|---|
| Uncertainty | 0.7 % |
| Procedure | Comparison to reference detectors |
| Parameters | Wavelength: 1310 nm, 1550 nm |
| Extend of service | Calibration performed at one wavelength |
| Quantity | Optical Power, singlemode |
| Extend of service | Additional calibration at another wavelength or power level |
| Quantity | Optical power, multimode -10 dBm |
| Uncertainty | 1.1 % |
| Procedure | Comparison to reference detectors |
| Parameters | Wavelength: 850 nm |
| Extend of service | Calibration performed at one wavelength |
| Quantity | Optical power, multimode |
| Extend of service | Additional calibration at another wavelength or power level |
| Quantity Uncertainty Procedure Parameters Extend of service | Linearity, singlemode 0.6 % Comparison to reference detectors or superposition technique Optical power: -5 dBm up to -65 dBm; wavelength: 1310 nm, 1550 nm Calibration performed at one wavelength |
| Quantity | Linearity, singlemode |
| Extend of service | Additional calibration at another wavelength |
| Quantity | Linearity, singlemode high power |
| Uncertainty | 1.5 % |
| Procedure | Comparison to reference detectors |
| Parameters | Optical power : 9 dBm up to -5 dBm; wavelength: 1550 nm |
| Extend of service | Calibration performed at 1550 nm |
| Quantity Uncertainty Procedure Parameters Extend of service | Linearity, multimode 0.7 % Comparison to reference detectors Optical power: -5 dBm up to -65 dBm; wavelength: 850 nm, 1330 nm Calibration performed at one wavelength |
| Quantity | Linearity, multimode |
| Extend of service | Additional calibration at another wavelength |
| Quantity | Polarisation dependency |
| Uncertainty | 0.7 % |
| Procedure | Polarisation scrambling |
| Parameters | Wavelength: 1310 nm, 1550 nm |
| Extend of service | Calibration performed at one wavelength |
| Quantity | Polarisation dependency |
| Extend of service | Additional calibration at another wavelength |
| Quantity Uncertainty Procedure Extend of service | Spectral Responsivity SM 1300 nm to 1800 nm 0.8 % Comparison with reference detectors Calibration in the specified wavelength range with 10 nm steps |

| Quantity | Spectral Responsivity MM 700 nm to 1250 nm |
|-------------------|--|
| Uncertainty | 0.9 % |
| Procedure | Comparison with reference detectors |
| Extend of service | Calibration in the specified wavelength range with 10 nm |
| | steps |

1.2. Attenuator

| Quantity Uncertainty Procedure | Linearity, singlemode 0.6 % Comparison to reference detector, according to IEC 61300-3- |
|--|--|
| Parameters | 14 Power level: -5 dBm up to -65 dBm |
| Quantity Uncertainty Procedure Parameters | Linearity, multimode 0.7 % Comparison to a reference detector Power level: -5 dBm up to -65 dBm |

1.3. I.L. and R.L. measuring instrument

| Quantity | Insertion and Return Loss | |
|-----------|---------------------------|--|
| Procedure | Simultaneous measurement | |

1.4. Optical switch

| Quantity | Channel Crosstalk, repeatability |
|-------------|----------------------------------|
| Uncertainty | 0.1 % |

1.5. Light source

| Qu | uantity | Optical power level -5 dBm up to -70 dBm |
|-----|------------------|---|
| Un | ncertainty | 0.9 % |
| Pri | ocedure | Comparison to reference detectors |
| Pa | nrameters | Wavelength: 850 nm, 1310 nm, 1550 nm |
| Ex | ttend of service | Calibration performed at one wavelength |
| Qı | uantity | Optical Power |
| Ex | tend of service | Additional calibration at another wavelength |
| Qu | uantity | Optical power stability -5 dBm up to -70 dBm |
| Un | ncertainty | 0.1 % |
| Pro | ocedure | Measurement with a reference powermeter |
| Pa | nrameters | Wavelength: 850 nm up to 1650 nm |
| Ex | ntend of service | Long term stability (2 hours) at one wavelength |
| Qı | uantity | Power stability |
| Ex | tend of service | Additional calibration at another wavelength |
| Qu | uantity | Optical spectrum, broadband source from 600 nm to 1700 nm |
| Un | ncertainty | 10 pm |
| Pro | ocedure | Measurement with a reference spectrum analyser |
| Ex | ttend of service | Spectrum, peak or mean wavelength, spectral width |
| Qu | uantity | Optical spectrum, broadband source |
| Ex | tend of service | Additional calibration at another wavelength |

| Quantity Uncertainty | Peak wavelength, narrowband sources from 600 nm to 1700 nm 1 pm |
|-------------------------------|--|
| Procedure | Measurement with a reference wavemeter |
| Extend of service | Calibration at one wavelength |
| Quantity Extend of service | Peak wavelength, narrowband source Additional calibration at another wavelength |
| Quantity | Encircled Flux |
| Uncertainty | 1 % |
| Procedure | According to IEC 61280-1-4, Ed. 2.0 |
| Parameters | Wavelength (850 nm, 1300 nm) |
| Extend of service | Calibration of the modal distribution at one wavelength |

1.6. Optical spectrum Analyser (OSA)

| Quantity Uncertainty Procedure Extend of service | Wavelength 633 nm, 1267 nm to 1365 nm, 1450 nm to 1641nm 10 pm Comparison to a reference-wavemeter Calibration in one wavelength domain by 5 nm steps |
|---|---|
| Quantity | Wavelength |
| Extend of service | Calibration in one additional wavelength domain |
| Quantity | Spectrum of the internal reference source |
| Quantity | Optical power -10 dBm |
| Uncertainty | 0.7 % |
| Procedure | Comparison to reference detectors |
| Parameters | Wavelength: 1310 nm, 1550 nm |
| Extend of service | Calibration performed at one wavelength |
| Quantity | Optical power |
| Extend of service | Additional calibration at another wavelength |
| Quantity | Polarisation dependancy |
| Uncertainty | 0.7 % |
| Procedure | Polarisation scrambling |
| Parameters | Wavelength: 1310 nm, 1550 nm |
| Extend of service | Calibration performed at one wavelength |

1.7. Optical wavemeter

| Quantity | Wavelength 1267 nm to 1365 nm, 1450 nm to 1641 nm |
|-------------------|---|
| Uncertainty | 0.4 pm |
| Procedure | Compariosn to a reference-wavemeter |
| Extend of service | Calibration in one wavelength domain by 5 nm steps |
| Quantity | Wavelength |
| Extend of service | Additional calibration in another wavelength domain |
| Quantity | Wavelength at 1542.383712 nm or at 633 nm |
| Procedure | Comparison to stabilized Reference lasers |
| Extend of service | Long term stability (2 hours) |

1.8. Optical time domain reflectometer (OTDR)

| Quantity | Deviation of the attenuation scale |
|--|--|
| Procedure | Comparison to a reference fibre |
| Parameters | Wavelength: 1300 nm, 1550 nm |
| Extend of service | Calibration performed with one set of parameters |
| Quantity Procedure Parameters Extend of service | Deviation of the attenuation scale Comparison to a reference fibre Wavelength: 1300 nm, 1550 nm Supplementary calibration performed with another set of pa- rameters |
| Quantity | Distance scale deviation |
| Procedure | Comparison to a reference ring resonator |
| Parameters | Wavelength:1300 nm, 1550 nm |
| Extend of service | Calibration performed with one set of parameters |
| Quantity Procedure Parameters Extend of service | Distance scale deviation Comparison to a reference ring resonator Wavelength:1300 nm, 1550 nm Supplementary calibration performed with another set of pa- rameters |

1.9. PMD measurement system

| Quantity | PMD, non mode coupled 0.3 ps |
|-------------------|--------------------------------------|
| Uncertainty | 0.05 ps |
| Procedure | Comparison to a reference waveplate |
| Parameters | Wavelength domain: 1300 nm, 1500 nm |
| Extend of service | Calibration in one wavelength domain |

2.Optical fibres and components

2.1. Optical fibre

| Quantity | Spectral attenuation, singlemode |
|---|--|
| Uncertainty | 0.03 dB |
| Procedure | Cut-back, according to IEC 60793-1-40 |
| Parameters | Wavelength: 900 nm up to 1700 nm; Spectral width: 5 nm |
| Extend of service | Wavelength step: 5 nm |
| Quantity | Chromatic dispersion |
| Uncertainty | Dispersion (ps/nm/km): 1 % |
| Procedure | Phase shift |
| Parameters | Wavelength: 1267 nm to 1365 nm; 1450 nm to 1641 nm |
| Extend of service | Calibration of the chromatic dispersion in one spectral domain |
| Quantity Uncertainty Procedure Parameters Extend of service | Chromatic dispersion Dispersion slope (ps/nm/nm//km): 1 %, zero disp. wavel- ength: 60 pm Phase shift Wavelength: 1267 nm to 1365 nm; 1450 nm to 1641 nm Calibration of the zero dispersion wavelength and of the dis- persion slope |

| Quantity | Chromatic dispersion |
|-------------------|---|
| Extend of service | Additional calibration in another spectral domain |
| Quantity | Optical length of a singlemode fibre 0.1 m up to 100 km |
| Uncertainty | 0.005 m + 1*10^-5*L |
| Procedure | Transit time, according to IEC 60793-1-22 and IEC 61746 |
| Parameters | Wavelength: 1310 nm, 1550 nm |
| Extend of service | Calibration performed at one wavelength |
| Quantity | Optical length of a singlemode fibre |
| Extend of service | Additional calibration performed at another wavelength |
| Quantity | Optical fibre length, multimode 0.5 m up to 3 km |
| Uncertainty | 0.01 m + 5.8*10^-4*L |
| Procedure | Transit time, according to IEC 60793-1-22 and IEC 61746 |
| Parameters | Wavelength: 850 nm, 1310 nm |
| Extend of service | Calibration performed at one wavelength |
| Quantity | Optical length of a multimode fibre |
| Extend of service | Additional calibration at another wavelength |

2.2. Passive components

| Quantity Uncertainty | Curvature radius, undercut and apex offset Curvature radius: 0.075 mm, undercut: 0.6 nm, apex offset: 5 um |
|--|--|
| Procedure Extend of service | Interferometric measurement |
| | and apex offset |
| Quantity | Insertion and Return Loss IL: 0 dB to -30 dB, RL: 0dB to -50 dB |
| Procedure | According to IEC 61300-3-6, Ed. 3.0, Method 1 |
| Quantity Procedure Extend of service | Insertion and Return Loss According to IEC 60874-1 Additional calibration |
| Quantity Procedure Parameters | Encircled Flux (EF) Near field measurement with NIR camera Wavelength: 850 nm, 1300 nm |

3.Reference materials

3.1. Chromatic dispersion reference fibre

| Quantity | Chromatic dispersion |
|-------------------|--|
| Uncertainty | Dispersion (ps/nm/km): 1 %, dispersion slope (ps/nm/nm/km): |
| | 1 %, zero disp. wavelength: 60 pm |
| Procedure | Phase shift, according to IEC 60793-1-42 and IEC 61744 |
| Parameters | Fibre type: G652, G653, G655, DCF |
| Extend of service | The artefact is mounted in an instrument case and is fitted with two FC-PC or FC-APC chassis connectors |

3.2. Optical length reference fibre

| Quantity | Optical fiber length 0.4 m up to 100 km |
|-------------------|---|
| Uncertainty | 0.04 m @ L = 0.4 m, 17 m @ L = 100 km |
| Procedure | Transit time, according to IEC 60793-1-22 and IEC 61746 |
| Parameters | Fibre type: singlemode or multimode |
| Extend of service | The artefact is mounted in an instrument case |

3.3. Spectral attenuation reference fibre

| Quantity | Spectral attenuation |
|-------------------|---|
| Uncertainty | 0.03 dB |
| Procedure | Cut-back, according to IEC 60793-1-40 |
| Parameters | Wavelength: 900 nm up to 1700 nm; resolution: 5 nm |
| Extend of service | The Reference Fibre is delivered in a protective case |

3.4. Artefact for the calibration of OTDR

| Quantity Procedure | Artefact for the calibration of the attenuation This reference material allows to calibrate the attenuation scale of a singlemode OTDR. The artefact is mounted in an instrument case and is fitted |
|-----------------------|--|
| | with 2 FC-PC bulkhead connectors |
| Quantity Procedure | Artefact for the calibration of the distance This reference material is based on a ring resonator structure and allows to calibrate the distance scale of a singlemode OTDR. |
| Extend of service | The artefact is mounted in an instrument case |

3.5. Reference fibre for the effective group index of refraction

| Quantity | Effective group index of refraction |
|-------------------|---|
| Uncertainty | U neff (k=2): 0.0005 |
| Procedure | Phase shift, according to IEC 60793-1-42 and IEC 61744 |
| Parameters | Fibre type: G652, G653, G655, DCF |
| Extend of service | The artefact is mounted in an instrument case and is fitted with two FC-PC or FC-APC chassis connectors |

3.6. Reference fibre for the backscattering coefficient

| Quantity | Backscatter coefficient C (dB) |
|-------------------|---|
| Uncertainty | UC (k=2): 0.2 dB |
| Procedure | According to IEC 61746-1, Ed. 1.0, Annex G.3 |
| Parameters | Fibre type: G652, G653, G655, DCF |
| Extend of service | The artefact is mounted in an instrument case and is fitted with two FC-PC or FC-APC chassis connectors |

3.7. Reflectance standard

| Quantity | Reflectance (dB) |
|-------------------|---|
| Uncertainty | UC (k=2): 0.2 dB up to 2 dB |
| Parameters | Reference value: -3 dB up to -50 dB |
| Extend of service | The artefact is mounted in an instrument case and is fitted with one FC-APC chassis connector |